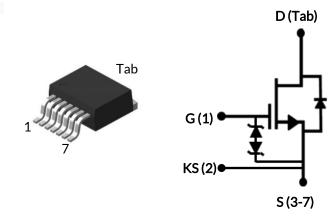


$1200V\text{-}150m\Omega\,\text{SiC}\,\text{Cascode}$

Rev. B, May 2023

DATASHEET

UF3C120150B7S



Part Number	Package	Marking
UF3C120150B7S	D ² PAK-7L	UF3C120150B7S



Description

This SiC FET device is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the D²PAK-7L package, this device exhibits ultralow gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads , and any application requiring standard gate drive.

Features

- On-resistance R_{DS(on)}: 150mΩ (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q_{rr} = 67nC
- Low body diode V_{FSD}: 1.46V
- Low gate charge: $Q_G = 25.7nC$
- Threshold voltage V_{G(th)}: 4.4V (typ) allowing 0 to 15V drive
- Package creepage and clearance distance > 6.1mm
- Kelvin source pin for optimized switching performance
- ESD protected, HBM class 2

Typical applications

Any controlled environment such as

- Telecom and Server Power
- Industrial power supplies
- Power factor correction modules
- Motor drives
- Induction heating





Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		1200	V
Gate-source voltage	V _{GS}	DC	-25 to +25	V
Continuous drain current ¹	1	T _C = 25°C	17	А
	ID	T _C = 100°C	12.5	А
Pulsed drain current ²	I _{DM}	T _C = 25°C	38	А
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} =2A	30	mJ
Power dissipation	P _{tot}	T _C = 25°C	136	W
Maximum junction temperature	T _{J,max}		175	°C
Operating and storage temperature	T _J , T _{STG}		-55 to 175	°C
Reflow soldering temperature	T _{solder}	reflow MSL 3	245	°C

1. Limited by $T_{J,max}$

2. Pulse width t_{p} limited by $T_{J,\text{max}}$

3. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.85	1.1	°C/W

Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Parameter	Complete	Test Conditions	Value			11.21.	
	Symbol		Min	Тур	Max	Units	
Drain-source breakdown voltage	BV _{DS}	V _{GS} =0V, I _D =1mA	1200			V	
Total drain leakage current		V _{DS} =1200V, V _{GS} =0V, T _J =25°C		2	50	- μΑ	
	I _{DSS}	V _{DS} =1200V, V _{GS} =0V, T _J =175°C		17			
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V		4	±20	μA	
Drain-source on-resistance	R _{DS(on)}	V _{GS} =12V, I _D =5A, T _J =25°C		150	180		
		V _{GS} =12V, I _D =5A, T _J =125°C		250		mΩ	
		V _{GS} =12V, I _D =5A, T _J =175°C		330			
Gate threshold voltage	V _{G(th)}	V _{DS} =5V, I _D =10mA	3.5	4.4	5.5	V	
Gate resistance	R _G	f=1MHz, open drain		4.6		Ω	

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Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			- Units
			Min	Тур	Max	Units
Diode continuous forward current ¹	ls	T _C =25°C			17	А
Diode pulse current ²	I _{S,pulse}	T _C =25°C			38	А
Forward voltage	V _{FSD}	V _{GS} =0V, I _S =5A, T _J =25°C		1.46	2	v
		V _{GS} =0V, I _S =5A, T _J =175°C		2		
Reverse recovery charge	Q _{rr}	V _R =800V, I _S =13A, V _{GS} =-5V, R _{G_EXT} =22Ω		67		nC
Reverse recovery time	t _{rr}	di/dt=1700A/µs, T_=25°C		24		ns
Reverse recovery charge	Q _{rr}	V _R =800V, I _S =13A, V _{GS} =-5V, R _{G_EXT} =22Ω		64		nC
Reverse recovery time	t _{rr}	di/dt=1700A/µs, T_J=150°C		24		ns





Typical Performance - Dynamic

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Input capacitance	C _{iss}	- V _{DS} =100V, V _{GS} =0V		738		
Output capacitance	C _{oss}	- f=100kHz -		58		pF
Reverse transfer capacitance	C _{rss}	1 100012		1.8		
Effective output capacitance, energy related	C _{oss(er)}	$V_{DS}=0V$ to 800V, $V_{GS}=0V$		34		pF
Effective output capacitance, time related	C _{oss(tr)}	V _{DS} =0V to 800V, V _{GS} =0V		68		pF
C _{OSS} stored energy	E _{oss}	V _{DS} =800V, V _{GS} =0V		10.8		μJ
Total gate charge	Q_{G}	– V _{DS} =800V, I _D =13A,		25.7		nC
Gate-drain charge	Q_{GD}	$V_{DS} = -5V \text{ to } 12V$		6		
Gate-source charge	Q _{GS}	- V _{GS} 5V to 12V		10		
Turn-on delay time	t _{d(on)}	V _{DS} =800V, I _D =13A, Gate		32		– ns
Rise time	t _r	Driver =-5V to +12V,		6		
Turn-off delay time	$t_{d(off)}$	Turn-on $R_{G,EXT}$ =8.5 Ω ,		32		
Fall time	t _f	 Turn-off R_{G,EXT}=20Ω Inductive Load, 		8		
Turn-on energy	E _{ON}	FWD: same device with		208		
Turn-off energy	E _{OFF}	V_{GS} =-5V, R_{G} =20 Ω ,		28		μJ
Total switching energy	E _{TOTAL}	T_=25°C		236		
Turn-on delay time	t _{d(on)}	V _{DS} =800V, I _D =13A, Gate		32		
Rise time	t _r	Driver =-5V to +12V,		5		
Turn-off delay time	$t_{d(off)}$	Turn-on R _{G,EXT} =8.5Ω, Turn-off R _{G,EXT} =20Ω Inductive Load,		32		ns
Fall time	t _f			7		
Turn-on energy	E _{ON}	FWD: same device with		201		
Turn-off energy	E _{OFF}	V _{GS} =-5V, R _G =20Ω,		23		μJ
Total switching energy	E _{TOTAL}	Tj=150°C		224		



Typical Performance Diagrams

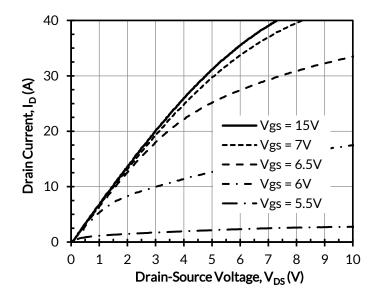


Figure 1. Typical output characteristics at $T_{\rm J}$ = - 55°C, tp < 250 μs

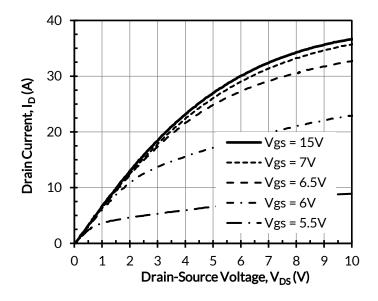


Figure 2. Typical output characteristics at T_J = 25°C, tp < 250 μ s

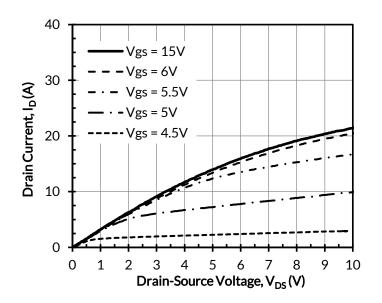


Figure 3. Typical output characteristics at T $_{\rm J}$ = 175°C, tp < 250 μs

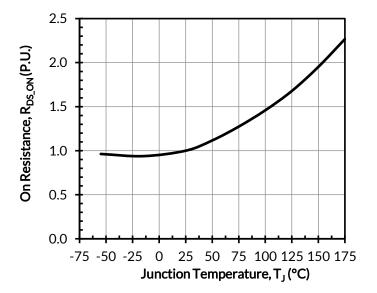


Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_D = 5A



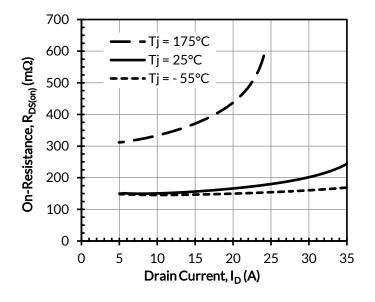


Figure 5. Typical drain-source on-resistances at V_{GS} = 12V

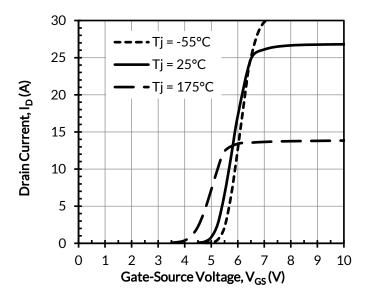


Figure 6. Typical transfer characteristics at V_{DS} = 5V

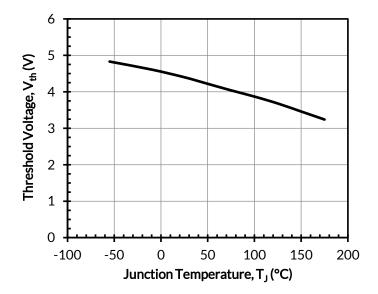


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA

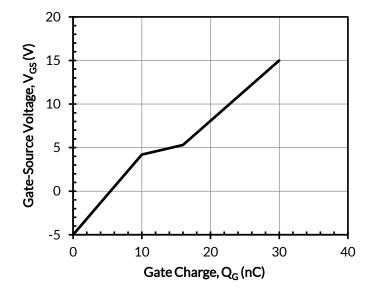


Figure 8. Typical gate charge at V_{DS} = 800V and I_{D} = 13A

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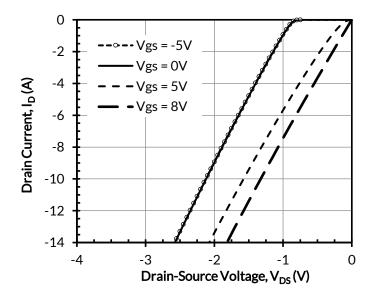


Figure 9. 3rd quadrant characteristics at $T_J = -55^{\circ}C$

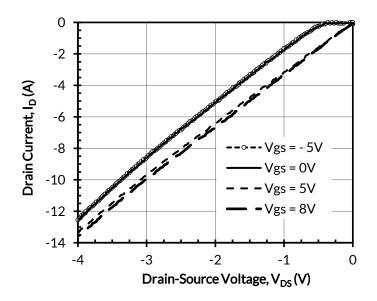


Figure 11. 3rd quadrant characteristics at T_J = 175°C

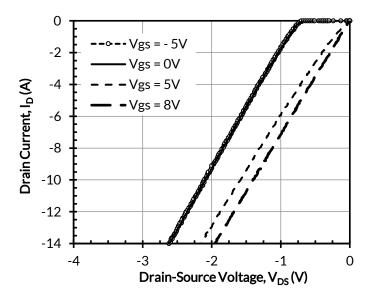


Figure 10. 3rd quadrant characteristics at $T_J = 25^{\circ}C$

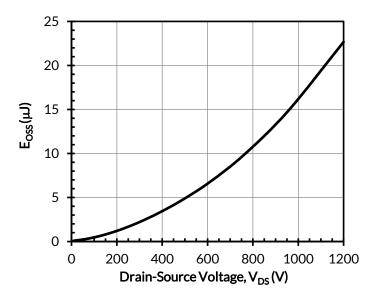


Figure 12. Typical stored energy in C_{OSS} at V_{GS} = 0V



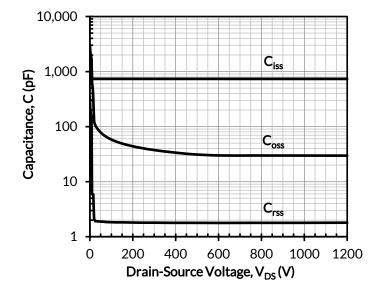


Figure 13. Typical capacitances at f = 100kHz and $V_{\rm GS}$ = 0V

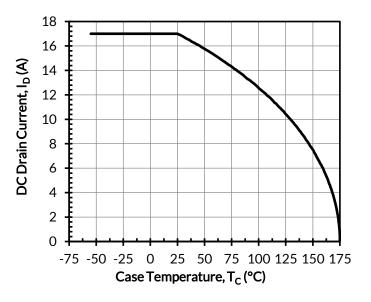


Figure 14. DC drain current derating

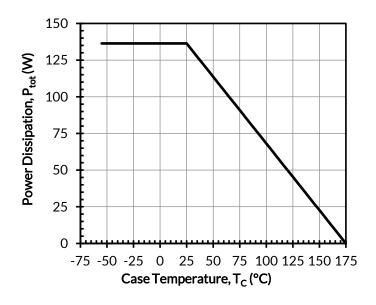


Figure 15. Total power dissipation

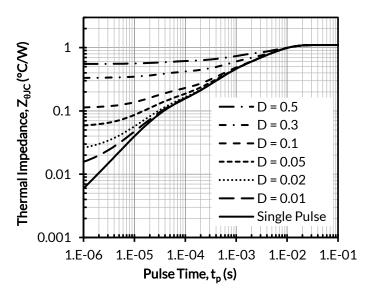


Figure 16. Maximum transient thermal impedance



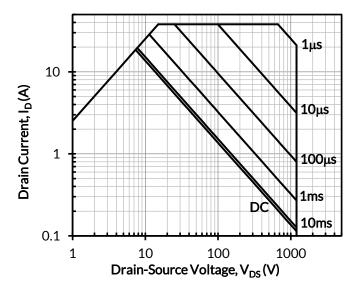


Figure 17. Safe operation area at T_{C} = 25°C, D = 0, Parameter $t_{\rm p}$

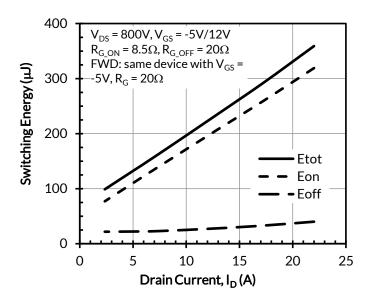


Figure 18. Clamped inductive switching energy vs. drain current at $T_J = 25^{\circ}C$

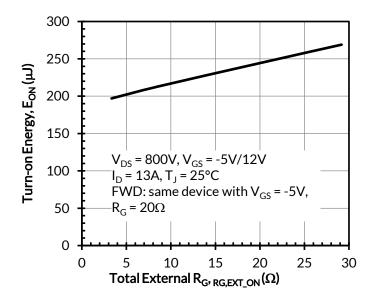


Figure 19. Clamped inductive switching turn-on energy vs. $R_{G,\text{EXT_ON}}$

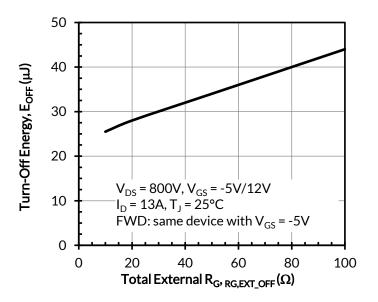


Figure 20. Clamped inductive switching turn-off energy vs. R_{G,EXT_OFF}

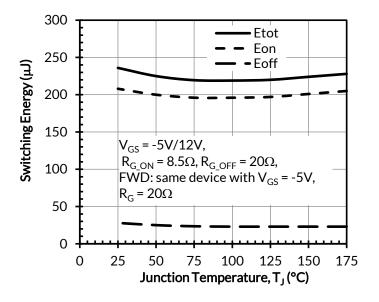
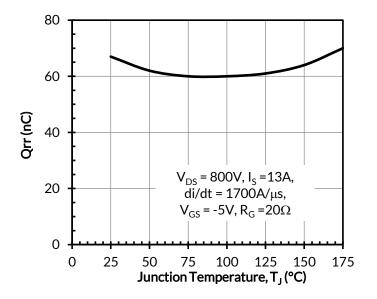


Figure 21. Clamped inductive switching energy vs. junction temperature at V_{DS} = 800V and I_D = 13A



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Figure 22. Reverse recovery charge Qrr vs. junction temperature

Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Q_{rr}) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

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Calculator

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

A snubber circuit with a small $R_{(G)}$, or gate resistor, provides better EMI suppression with higher efficiency compared to using a high $R_{(G)}$ value. There is no extra gate delay time when using the snubber circuitry, and a small $R_{(G)}$ will better control both the turn-off $V_{(DS)}$ peak spike and ringing duration, while a high $R_{(G)}$ will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high $R_{(G)}$, while greatly reducing $E_{(OFF)}$ from mid-to-full load range with only a small increase in $E_{(ON)}$. Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com





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